

<b>Notice of References Cited</b>	Application/Control No. 10/573,492		Applicant(s)/Patent Under Reexamination NANIWAE, KOICHI	
	Examiner ERIC W. JONES		Art Unit 2892	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,346,581 A	09-1994	Tsang, Won-Tien	117/97
*	B	US-5,400,740 A	03-1995	Goto et al.	117/91
*	C	US-5,407,531 A	04-1995	Chiu et al.	117/97
*	D	US-5,679,603 A	10-1997	Kimura et al.	117/104
*	E	US-5,785,755 A	07-1998	Nakamura et al.	117/104
*	F	US-5,827,365 A	10-1998	Shimoyama et al.	117/94
*	G	US-5,946,582 A	08-1999	Bhat, Rajaram	438/311
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP-2003-282455-A	03-2003	Japan	Koichi, Nanbae	H01L 21/205
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

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